

## Notice of References Cited

Application/Control No.	Applicant(s)	Patent Under	
09/597,428	CRANDALL,	Applicant(s)/Patent Under Reexamination CRANDALL, EVAN STEPHEN	
Examiner	Art Unit		
April L Baugh	2141	Page 1 of 1	

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	А	US-6,029,045	02-2000	Picco et al.	725/34
	В	US-6,684,249	01-2004	Frerichs et al.	709/225
	С	US-6,345,293	02-2002	Chaddha, Navin	709/219
	D	US-			
	Ε	US-			
	F	US-			
	G	US-			
	Н	US-			
	ı	US-			
	J	US-			
	к	US-			
	L	US-			
	м	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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## **NON-PATENT DOCUMENTS**

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*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)			
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

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